

Notice of References Cited	Application/Control No. 10/580,832		Applicant(s)/Patent Under Reexamination SUH ET AL.	
	Examiner JENNIFER DOAN		Art Unit 2874	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,357,510 B2	04-2008	Kim et al.	353/7
*	B	US-6,513,953 B1	02-2003	Itoh, Yoshitaka	362/331
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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